

Notice of References Cited	Application/Control No. 10/525,707		Applicant(s)/Patent Under Reexamination FUNATSU ET AL.	
	Examiner David M. Naff		Art Unit 1657	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,284,451	09-2001	Funatsu et al.	435/1.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	J	US-			
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FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

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